Power MOSFET

40 V, 3 m Ω , 107 A, Single N-Channel

Features

- Small Footprint (3.3x3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	40	V
Gate-to-Source Voltage	e		V_{GS}	±20	V
Continuous Drain		T _C = 25°C	I _D	107	Α
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		75	
Power Dissipation	State	T _C = 25°C	P_{D}	68	W
R _{θJC} (Note 1)		T _C = 100°C		34	
Continuous Drain		T _A = 25°C	I _D	23	Α
Current R _{0JA} (Notes 1, 2, 3)	Steady	T _A = 100°C		16	
Power Dissipation	State	T _A = 25°C	P_{D}	3.3	W
R _{θJA} (Notes 1 & 2)		T _A = 100°C		1.6	
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	740	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to +175	°C
Source Current (Body Diode)			I _S	76	Α
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 7 A)			E _{AS}	215	mJ
Lead Temperature for S (1/8" from case for 10 s)		urposes	TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{ heta JC}$	2.2	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	46	

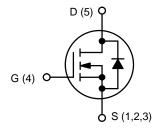
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
40 V	3 mΩ @ 10 V	407.4	
40 V	4.8 mΩ @ 4.5 V	107 A	



N-CHANNEL MOSFET



WDFN8 (μ8FL) CASE 511AB



MARKING

453L = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Cond	ition	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D =$: 250 μA	40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				1.6		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	T _J = 25 °C			10	
		$V_{DS} = 40 \text{ V}$	T _J = 125°C			250	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = 20 V			100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 60 μΑ	1.2	1.65	2.0	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.3		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 40 A		2.5	3	
		V _{GS} = 4.5 V	I _D = 40 A		3.8	4.8	mΩ
Forward Transconductance	9FS	V _{DS} = 15 V, I _E	o = 40 A		120		S
CHARGES AND CAPACITANCES					-		
Input Capacitance	C _{ISS}				2100		pF
Output Capacitance	C _{OSS}	$V_{GS} = 0 \text{ V, f} = 1 \text{ MH}$	z, V _{DS} = 25 V		1000		
Reverse Transfer Capacitance	C _{RSS}				42		1
Output Charge	Q _{OSS}	V _{GS} = 0 V, V _{DD} = 20 V			31		nC
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 40 A			35		
Total Gate Charge	Q _{G(TOT)}				16		1
Threshold Gate Charge	Q _{G(TH)}				4.0		nC
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 2$	20 V; I _D = 40 A		7.0		
Gate-to-Drain Charge	Q_{GD}				5.0		
Plateau Voltage	V_{GP}				3.2		V
Gate Resistance	R _G	T _A = 25°C			1.2		Ω
SWITCHING CHARACTERISTICS (Note 5)						
Turn-On Delay Time	t _{d(ON)}				11		
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{D}$	_{IS} = 20 V,		110		1
Turn-Off Delay Time	t _{d(OFF)}	$I_D = 40 \text{ A}, R_G = 2.5 \Omega$			21		ns
Fall Time	t _f				5		
DRAIN-SOURCE DIODE CHARACTERIS	TICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.84	1.2	.,,
		I _S = 40 A	T _J = 125°C		0.72		V
Reverse Recovery Time	t _{RR}		-		41		
Charge Time	ta	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 40 \text{ A}$			19		ns
Discharge Time	t _b				22		1
Reverse Recovery Charge	Q_{RR}				30		nC

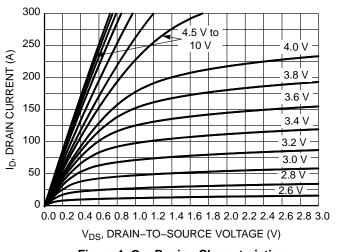
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

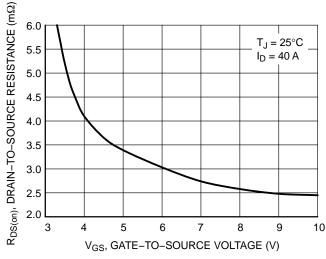
300



250 V_{DS} = 5 V V

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



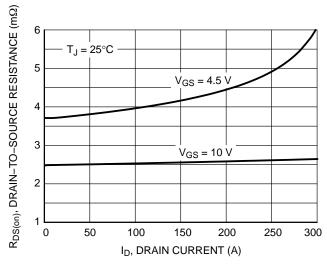
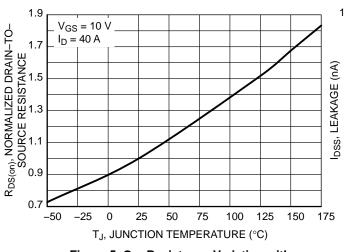


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



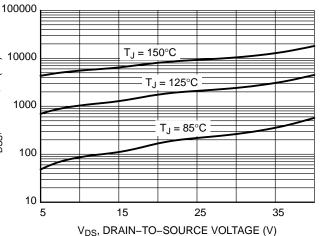
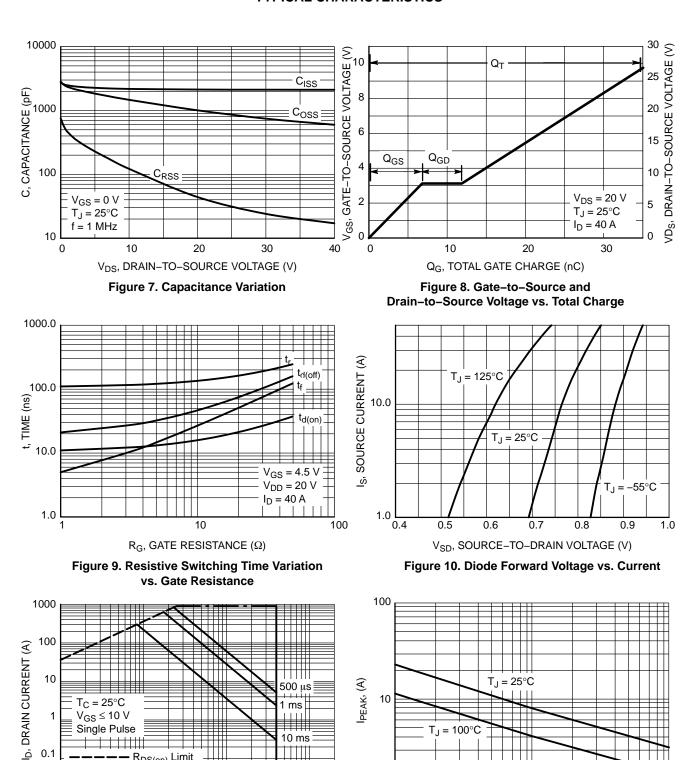


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS



V_{DS} (V) Figure 11. Safe Operating Area

10

R_{DS(on)} Limit Thermal Limit Package Limit

Single Pulse

0.1

0.01

0.1

TIME IN AVALANCHE (s) Figure 12. $I_{\mbox{\scriptsize PEAK}}$ vs. Time in Avalanche

1E-3

10E-2

 $T_{.1} = 100^{\circ}C$

1 L 1E-4

10 ms

100

TYPICAL CHARACTERISTICS

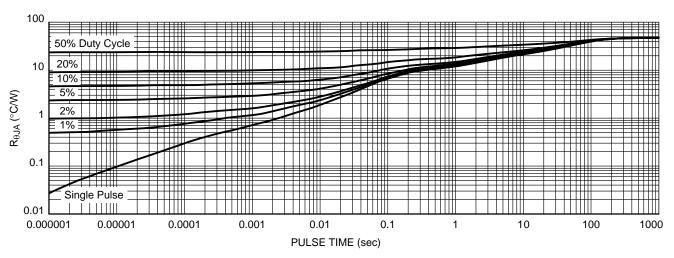


Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NTTFS5C453NLTAG	453L	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS5C453NLTWG	453L	WDFN8 (Pb-Free)	5000 / Tape & Reel

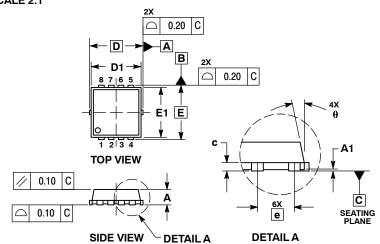
[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

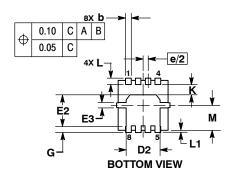
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC	;	0	.130 BSC	
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		0	.130 BSC	
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е		0.65 BSC		(0.026 BS	0
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
M	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location Α

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

SOLDERING FOOTPRINT*
8X 0.42 A COMMITTED AND ACKAGE AX PITCH F0.66
PACKAGE OUTLINE
<u> </u>
3.60
0.75 0.57 2.30
0.47
3.46

DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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PAGE 2 OF 2

ISSUE	ISSUE REVISION		
0	RELEASED FOR PRODUCTION. REQ. BY B. MOSHER.	30 MAY 2008	
Α	ADDED GENERIC MARKING INFORMATION. REQ. BY B. MOSHER.	07 AUG 2008	
В	CHANGED MAX DIMENSION "B" FROM 0.41MM TO 0.40MM. REQ. BY NK THEN.	20 JAN 2009	
С	ADDED DIMENSION E3. REQ. BY N. ZAINAL.	04 NOV 2011	
D	CORRECTED DIMENSION K VALUES. REQ. BY D. TRUHITTE.	23 APR 2012	

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